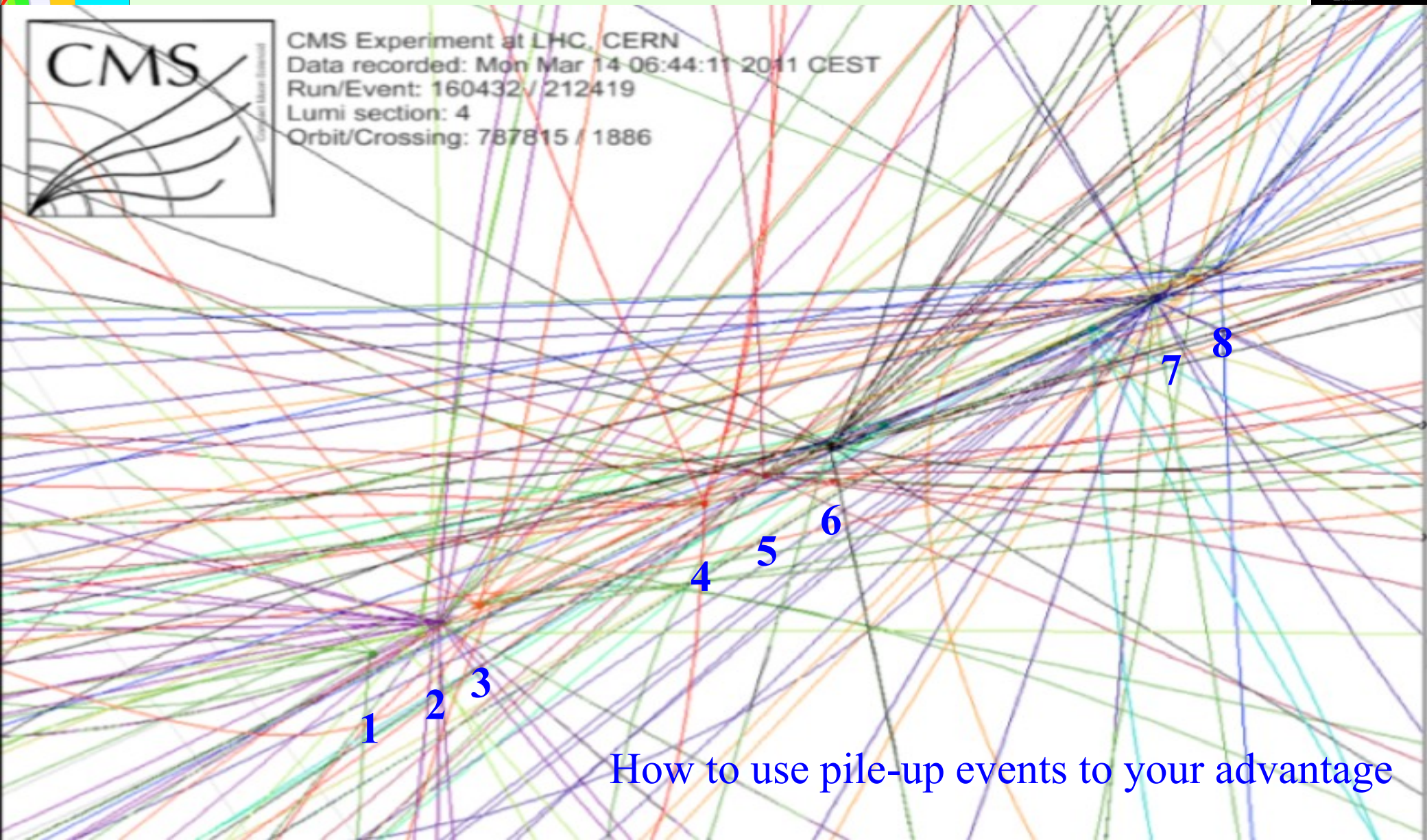




“Measurement of the pp inelastic cross section using pile-up events with the CMS detector”



CMS Experiment at LHC, CERN
Data recorded: Mon Mar 14 06:44:11 2011 CEST
Run/Event: 160432 / 212419
Lumi section: 4
Orbit/Crossing: 787815 / 1886



How to use pile-up events to your advantage

Analysis technique



The probability of having n_{pileup} depends only on the total $\sigma(pp)$ cross section:

$$P(n_{\text{pileup}}) = \frac{(L * \sigma)^{n_{\text{pileup}}} * e^{-(L * \sigma)}}{n_{\text{pileup}}!}$$

If we count the number of pile-up events as a function of luminosity, we can measure $\sigma(pp)$.

For an accurate measurement we need a large luminosity interval.



Steps



1. Acquire the bunch crossing using a primary event:

the bunch crossing is recorded because there was an event that fired the trigger.

We don't use this primary event, we only use it to record the bunch crossing

2. Count the number of pile-up events:

for any give bunch crossing, we count the number of vertices in the event.

3. Correct the number of visible vertices for various effects:

vertex merging, vertex splitting, real secondary vertices...

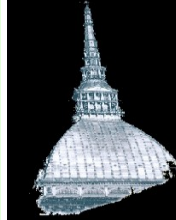
4. Fit the probability of having $n = 0, \dots, 8$ pile-up events as a function of luminosity:

using a Poisson fit, we obtain 9 values of $\sigma(pp)_n$

5. Fit the 9 values together:

from $\sigma(pp)_n$ we obtain $\sigma(pp)$

Luminosity and pile-up events



LHC is doing really well, it has reached a record instantaneous luminosity of $1.7 \cdot 10^{33} \text{ cm}^{-2} \text{ s}^{-1}$. However for this study the important parameter is the **instantaneous luminosity per bunch** (currently 1080 bunches)

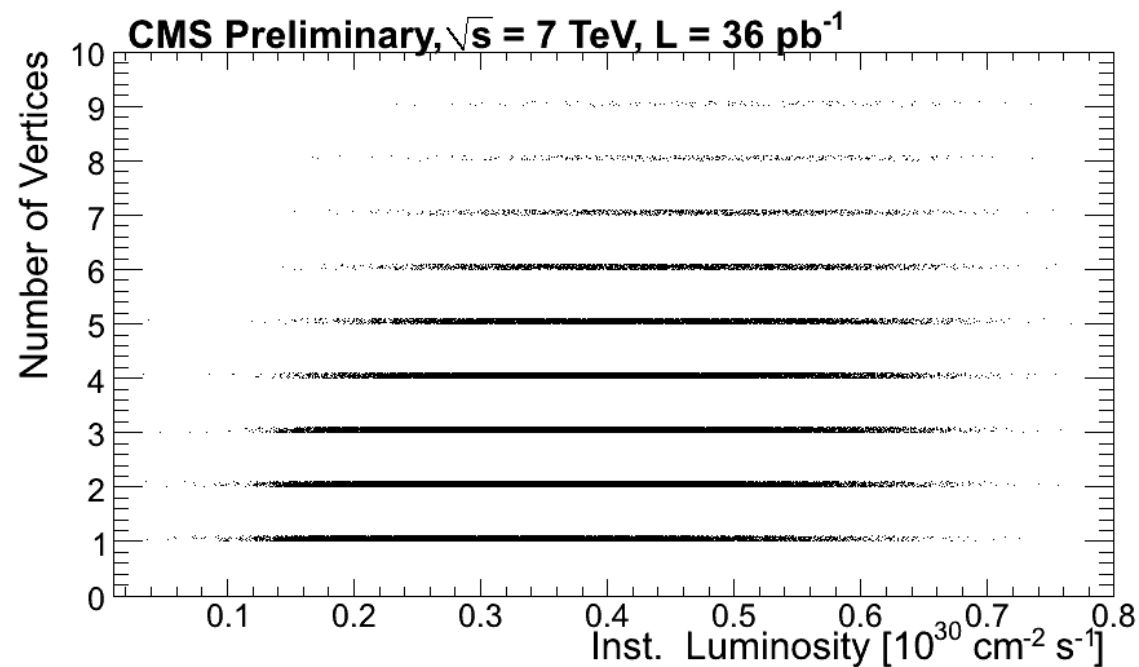
We studied events with:

0-8 pile-up events

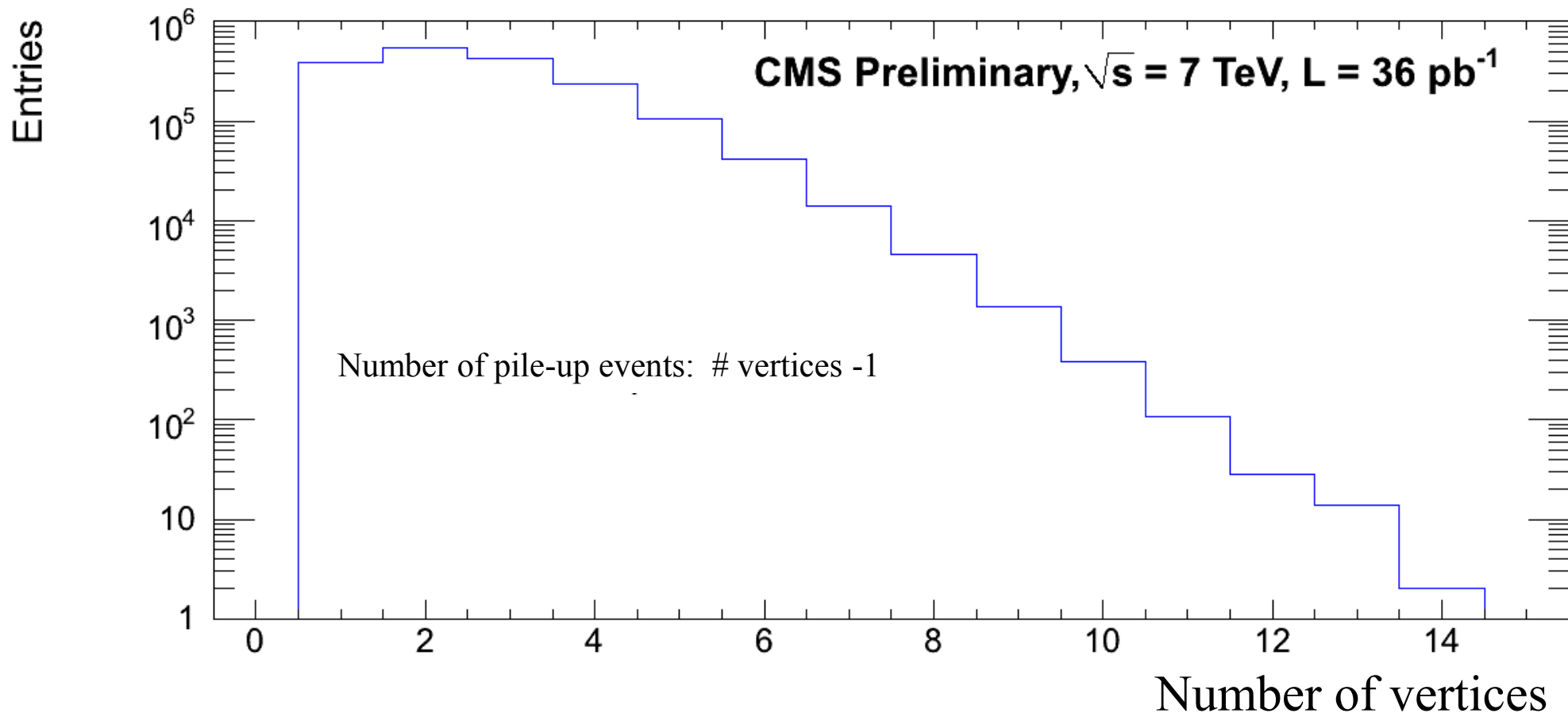
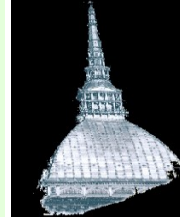
and

luminosity range $0 - 0.7 \cdot 10^{30} \text{ cm}^{-2} \text{ s}^{-1}$

(2010 data taking period)

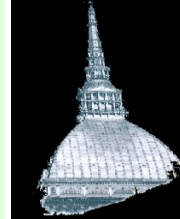


How many pile-up events are there?

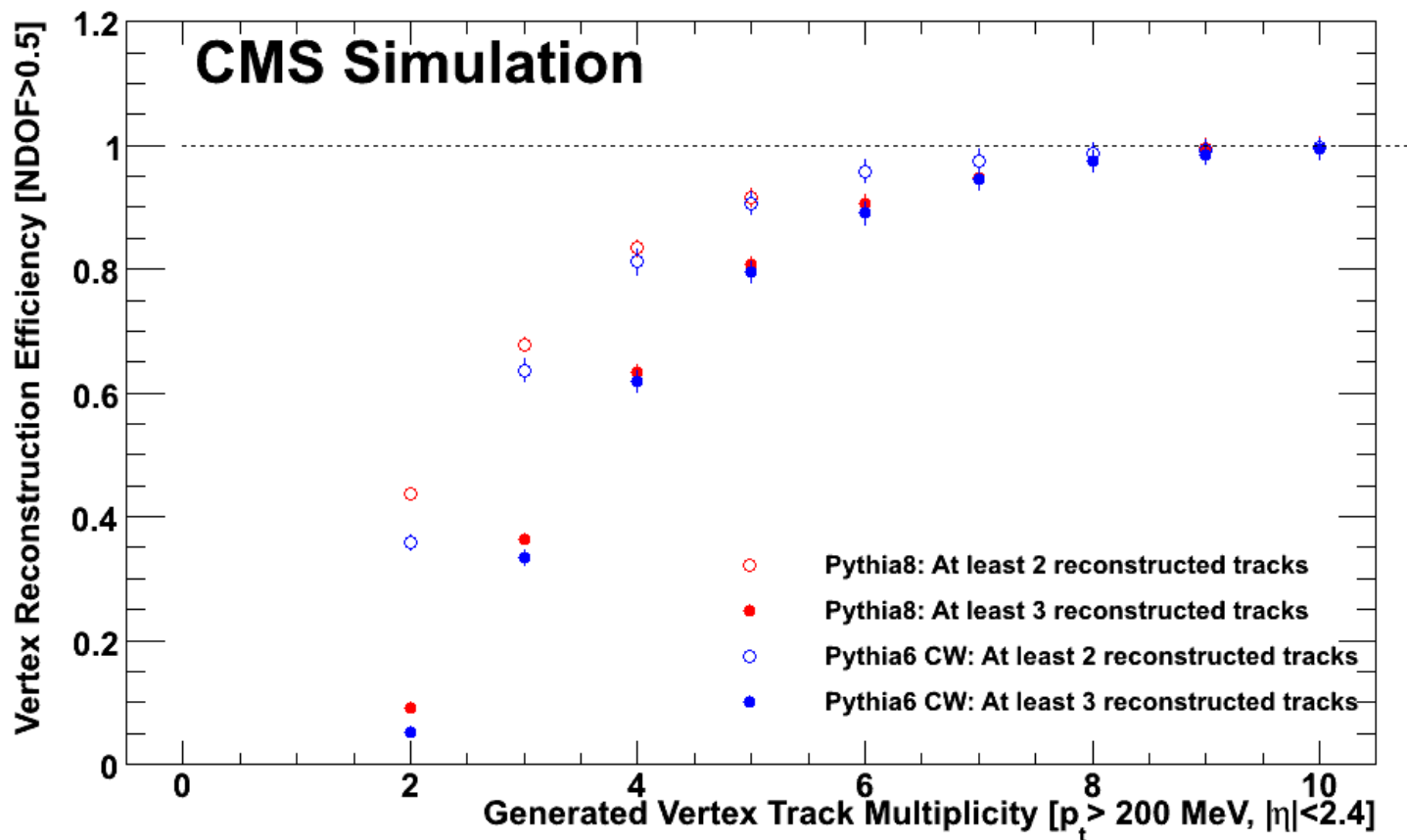


We studied events with 0-8 pile-up events (non enough statistics to go further)

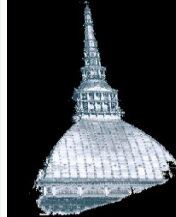
Vertex reconstruction



The goal of the analysis is to count the number of pile-up events as a function of luminosity. This means we need to count vertices.



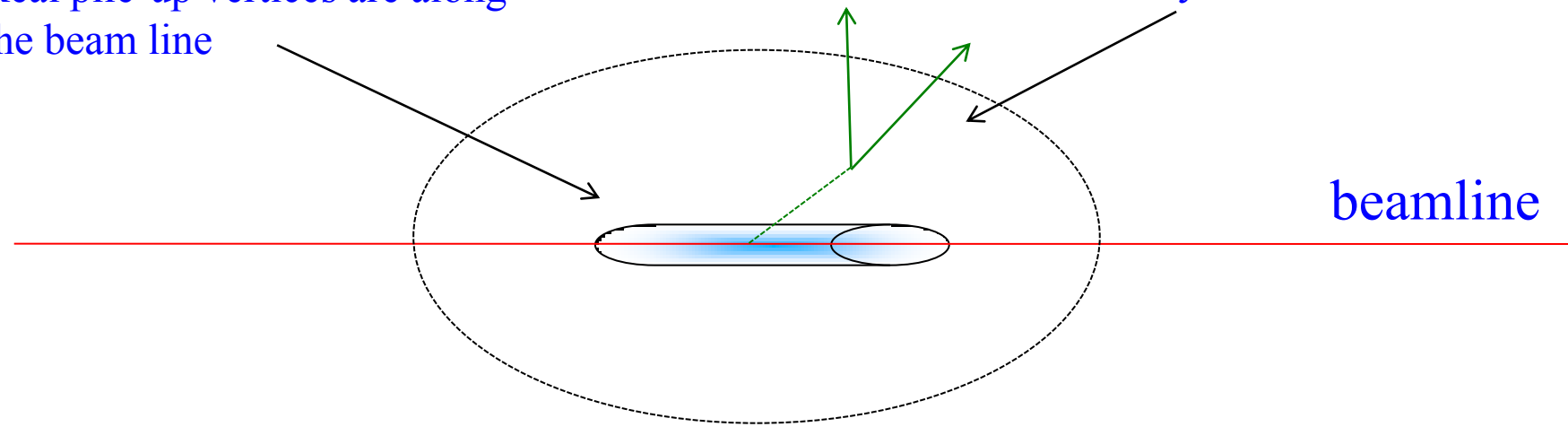
Vertex requirements



Position along the beam line:

Real pile-up vertices are along the beam line

Secondary (fake and real) vertices are everywhere



beamline

Quality cut:

- At least 3 tracks with $p_t > 200$ MeV in $|\eta| < 2.4$.
- Each track should have at least 2 pixel hits and 5 strip hits
- The vertex should pass an overall quality cut, $NDOF > 0.5$



Vertex merging and secondary vertices



Vertex merging:

When two vertexes overlap they are merged into a single one.

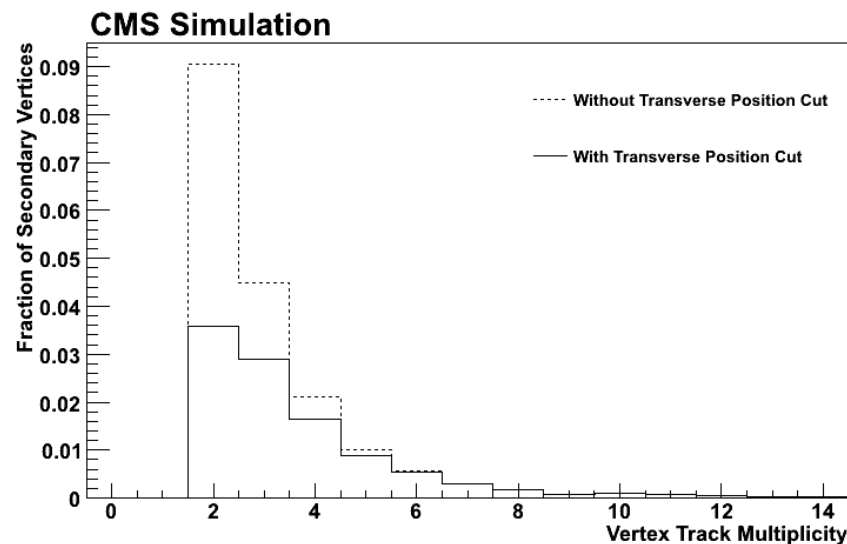
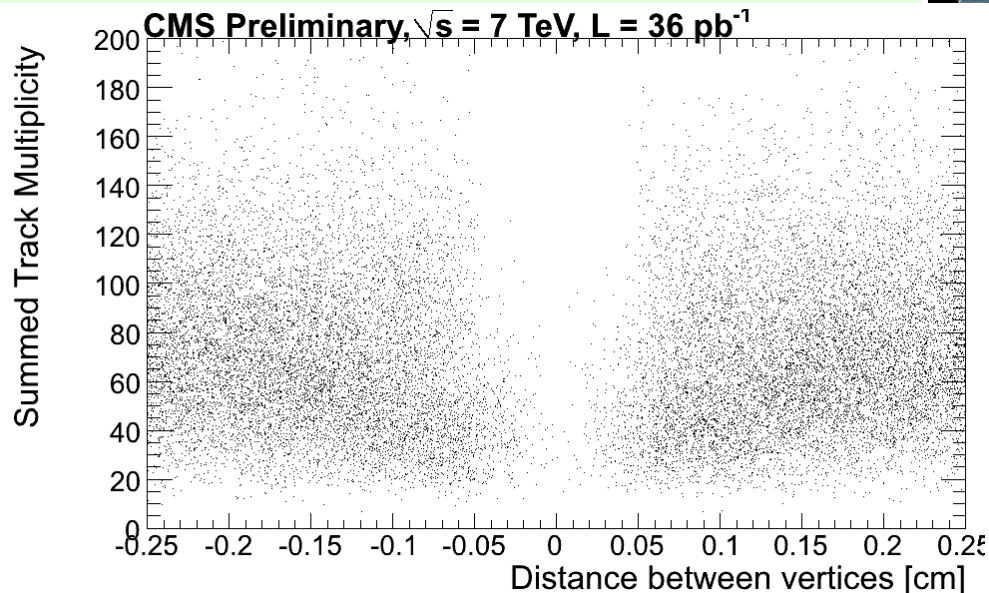
This blind distance is ~ 0.06 cm

Secondary vertices:

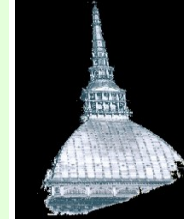
1. Fakes from the reconstruction program
2. Real non prompt decay

Both reduced by the request on the transverse position

Most evident at low track multiplicity

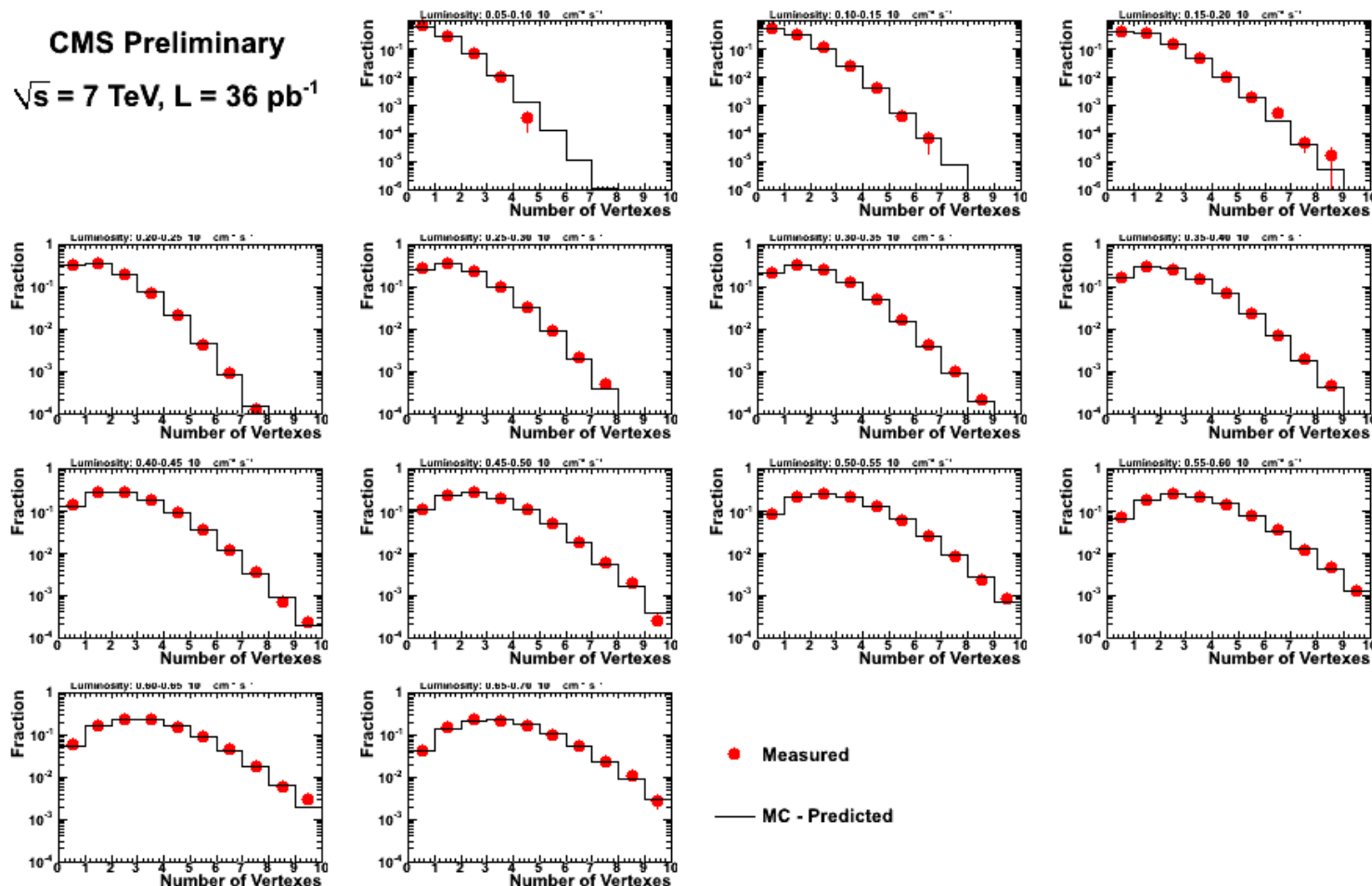


Simulation - I

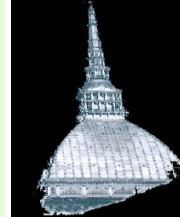


This analysis uses only the simulation of the vertex efficiency, which does not depend on the specific physics model

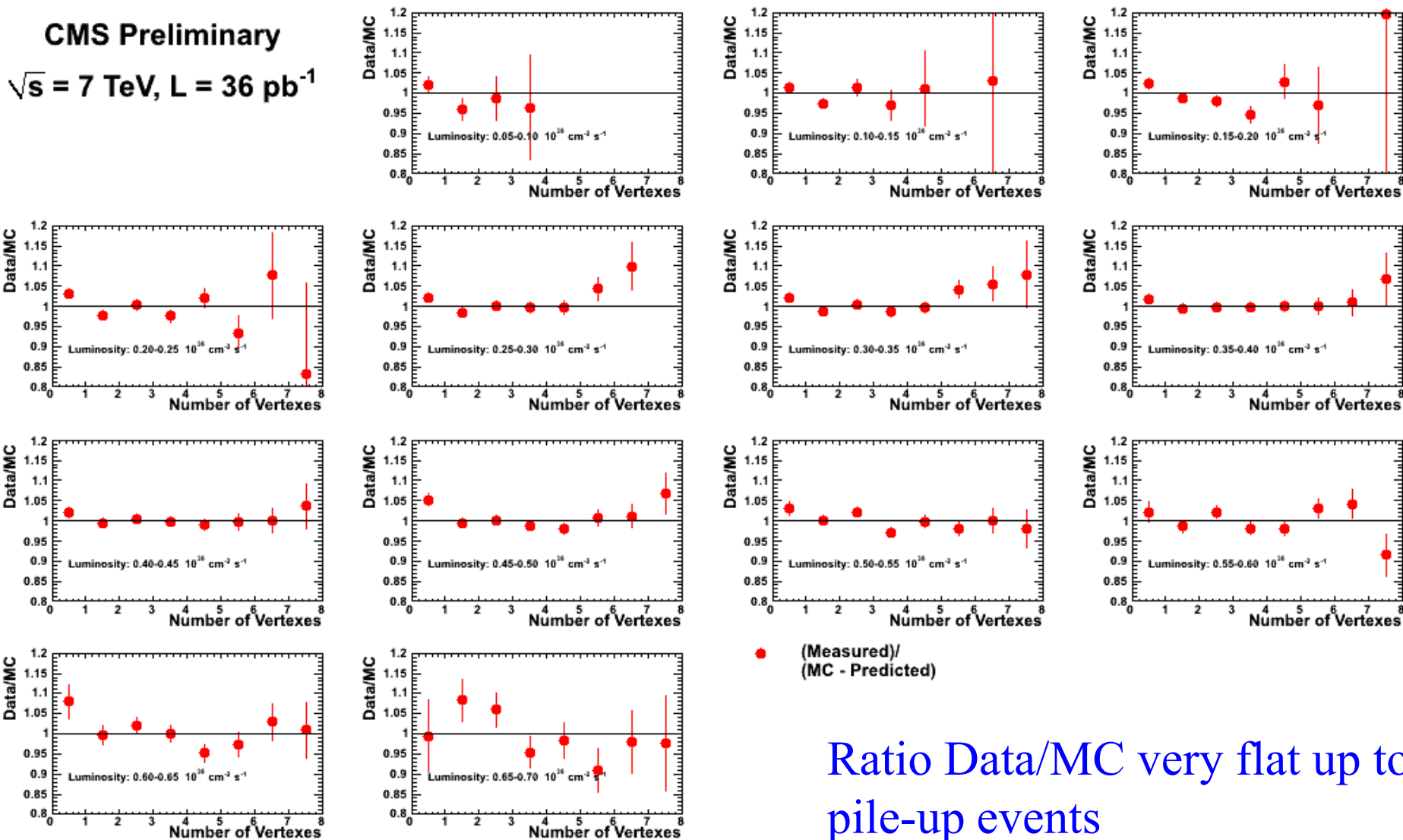
- 1) Data divided into 13 luminosity bins
- 2) In each luminosity bin we count the vertices



Simulation - II

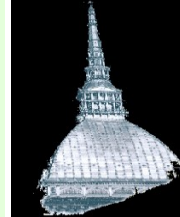


CMS Preliminary
 $\sqrt{s} = 7 \text{ TeV}, L = 36 \text{ pb}^{-1}$



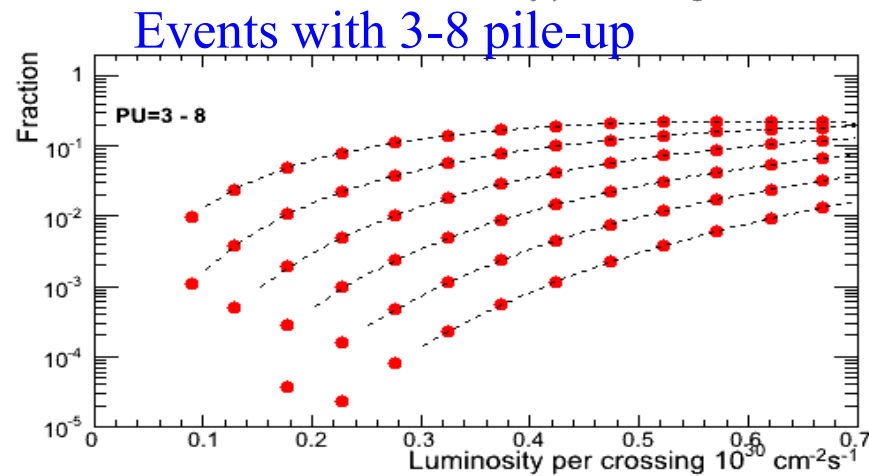
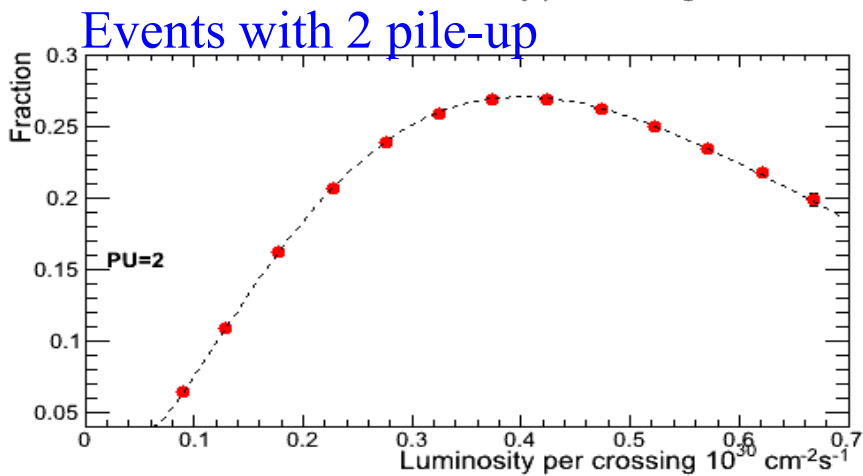
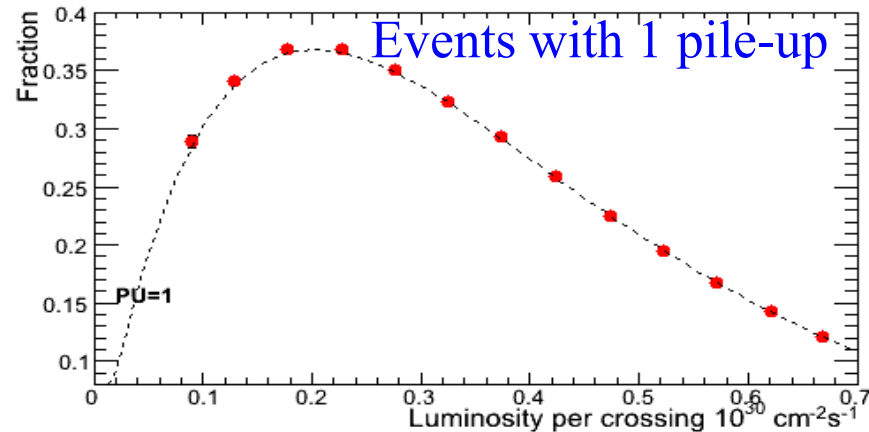
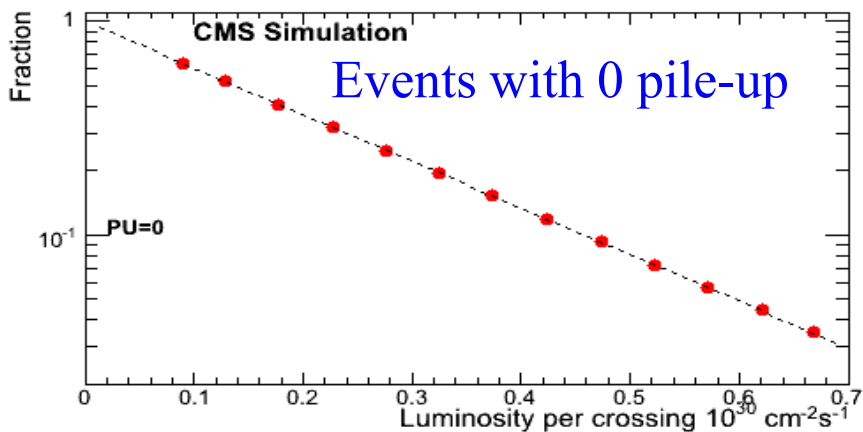
Ratio Data/MC very flat up to 8 pile-up events

Simulation- III: Does this idea work?

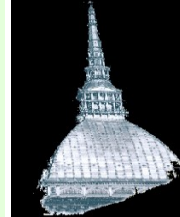


We have done the analysis using simulated events as real data:

1. We impose a Monte Carlo total inelastic cross section (64 mb)
2. At generation the fraction of events with 3 tracks, $|\eta| < 2.4$: 56.3 mb (88%)

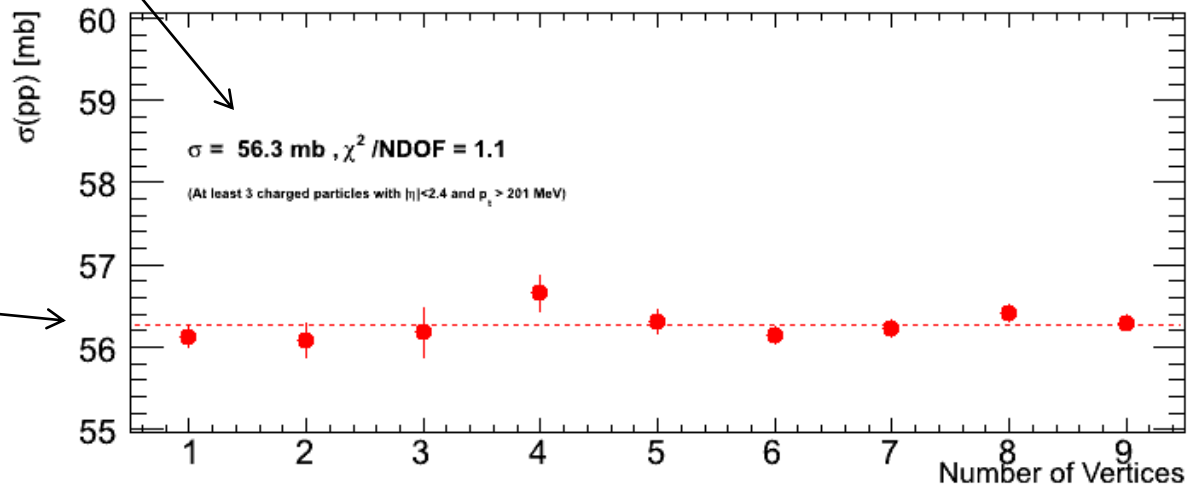
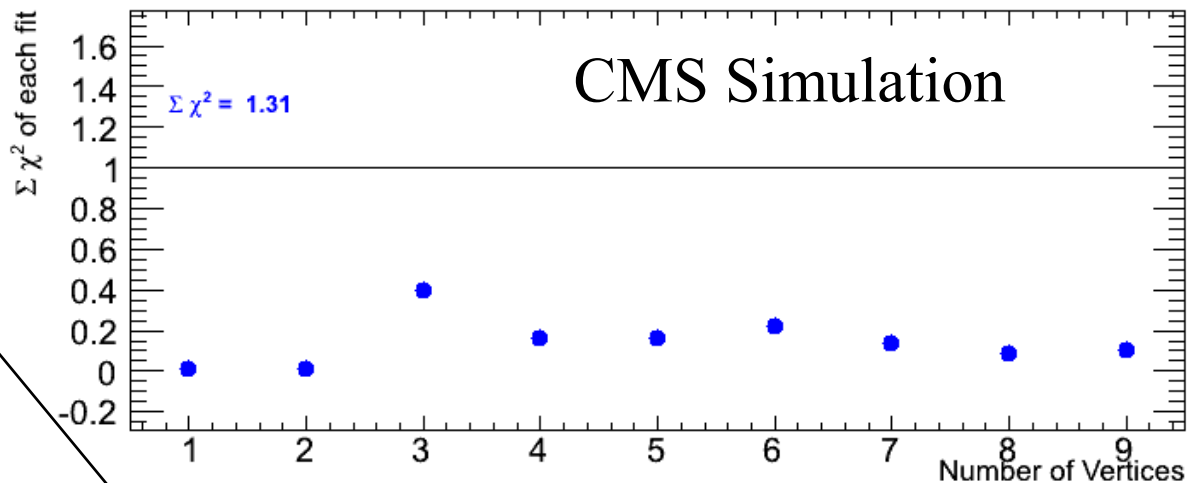


Simulation – IV: Results



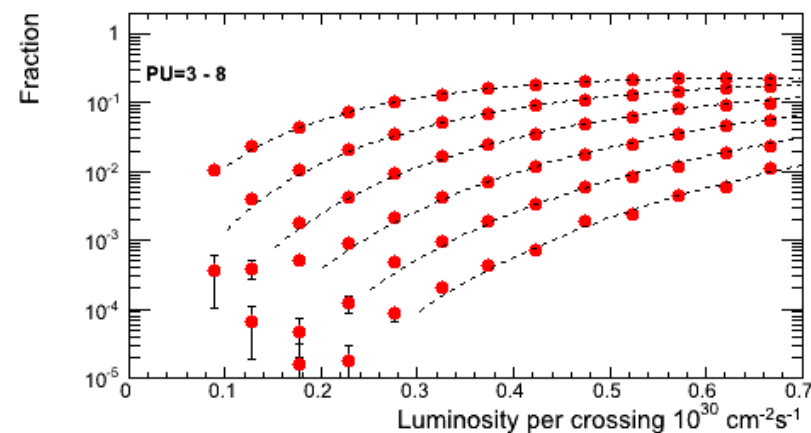
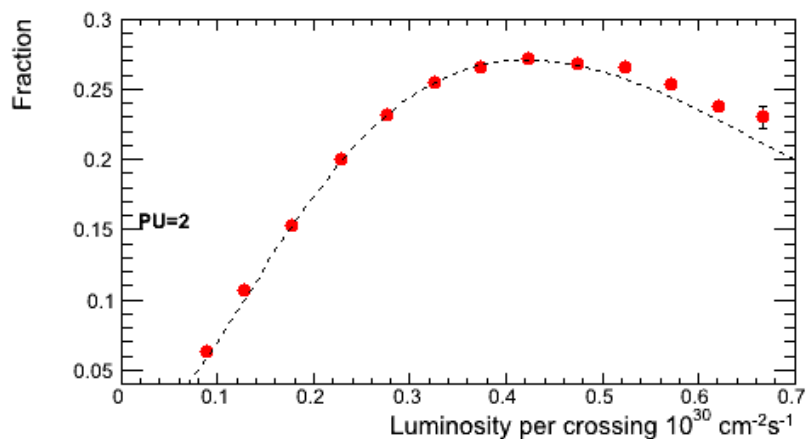
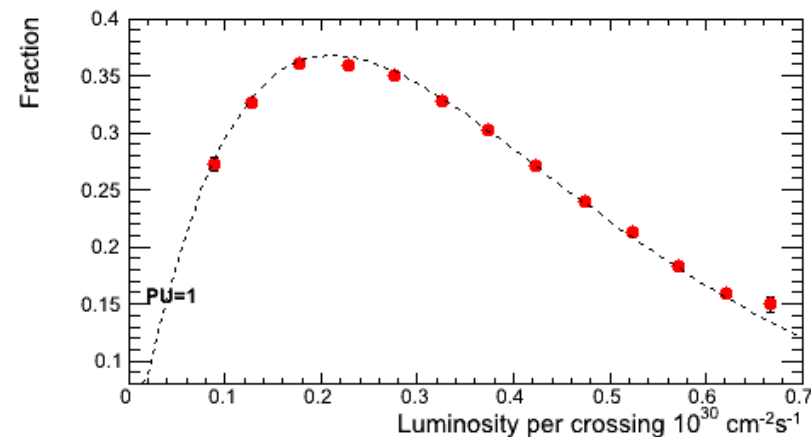
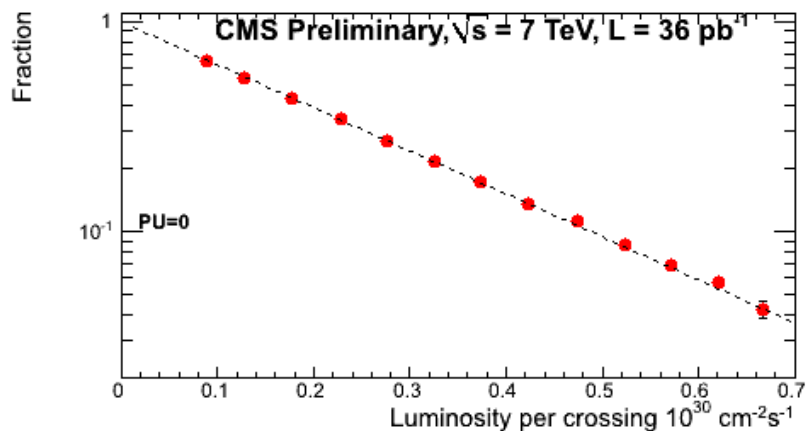
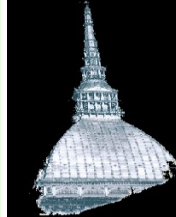
Result from fit: 56.3 mb

(At generation: 56.3...)



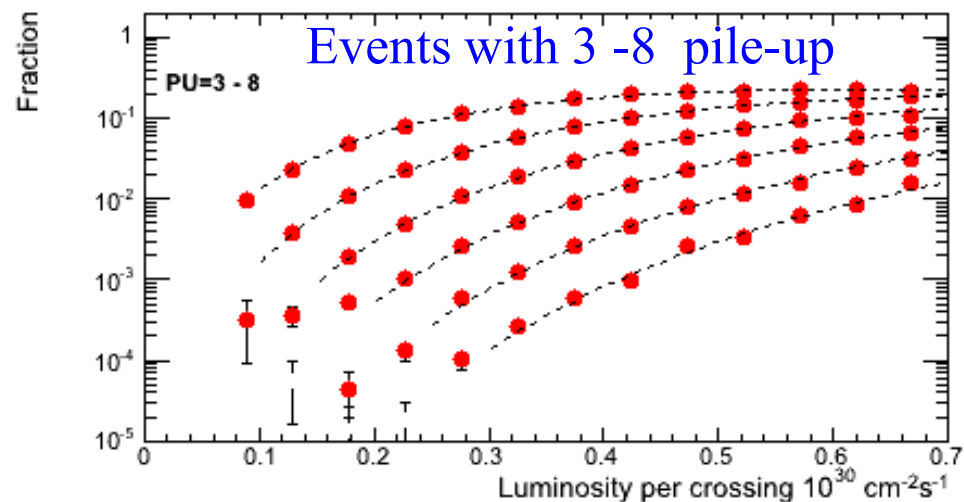
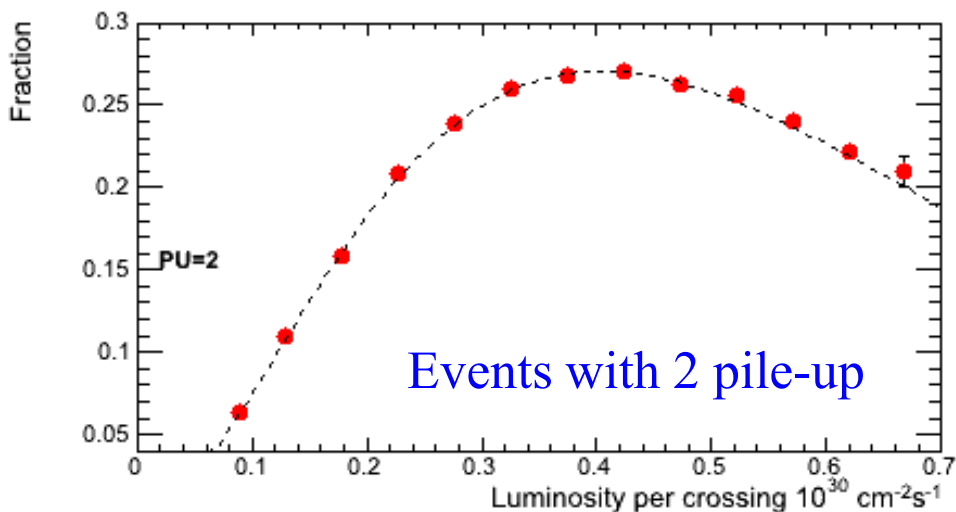
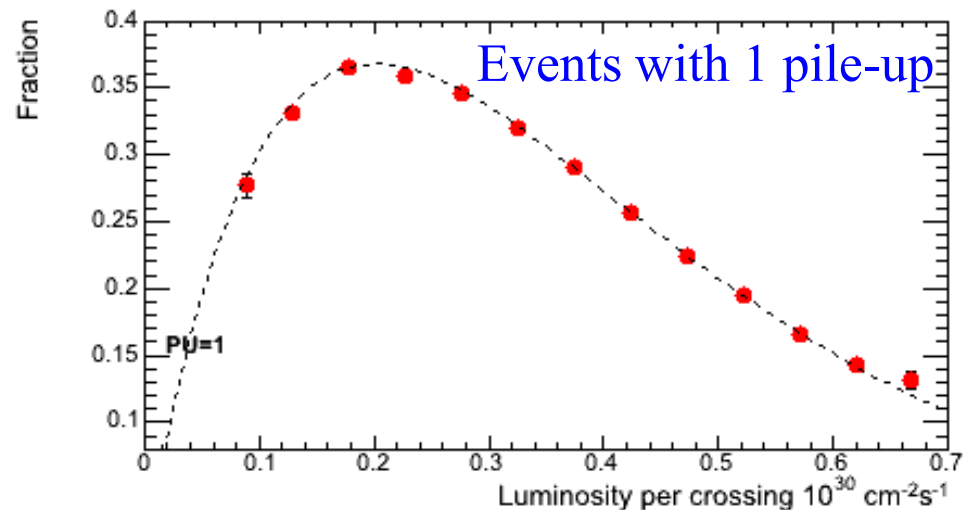
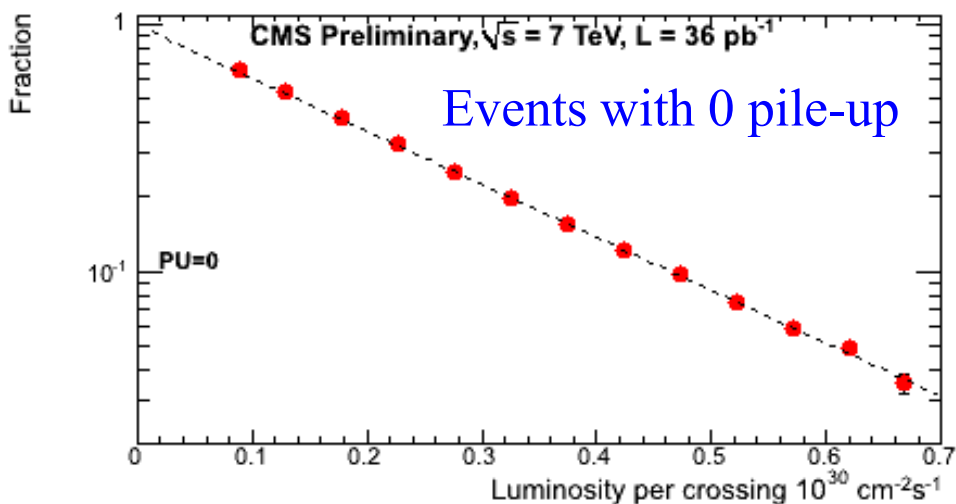
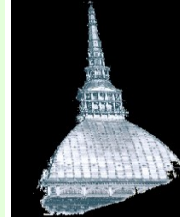
Fit from different pile-up numbers

Data: uncorrected distributions



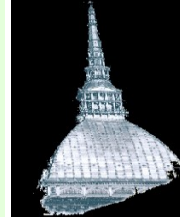
Given the very good CMS vertex efficiency, good fits even without corrections

Data: corrected distributions





Fitted Cross Section

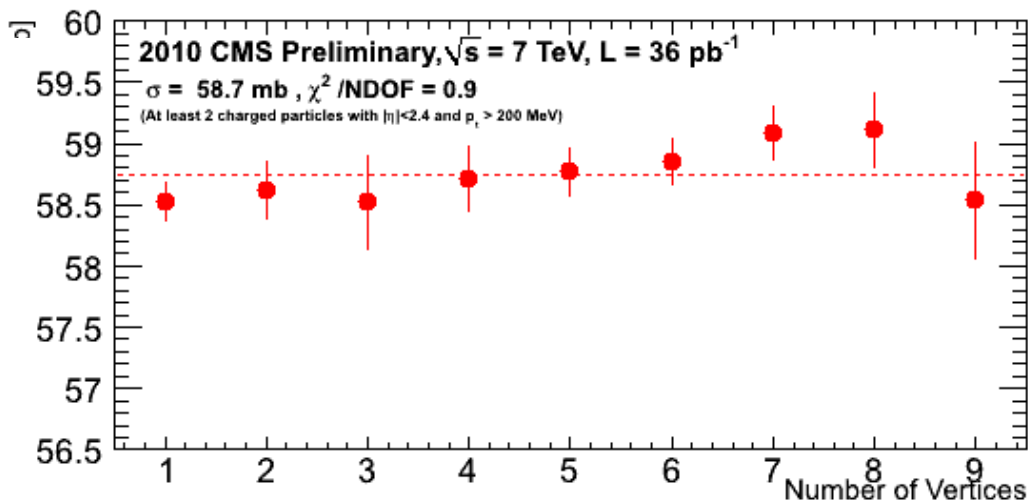
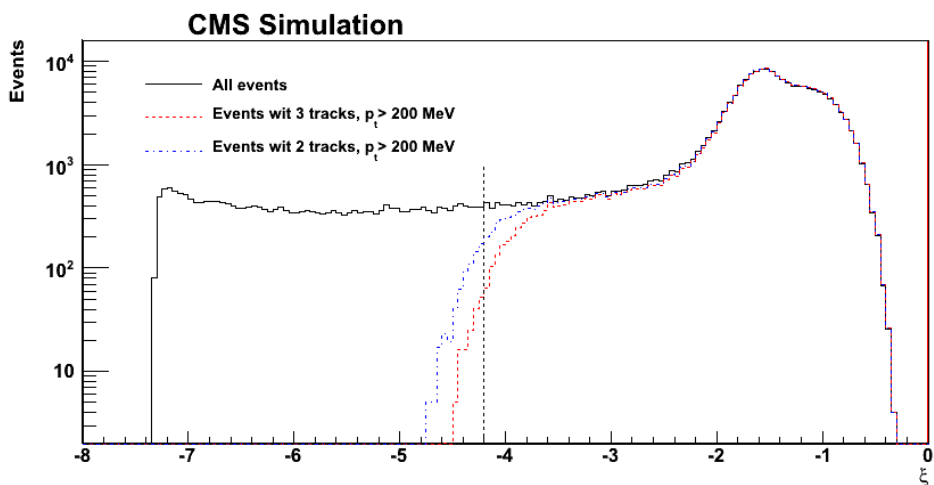
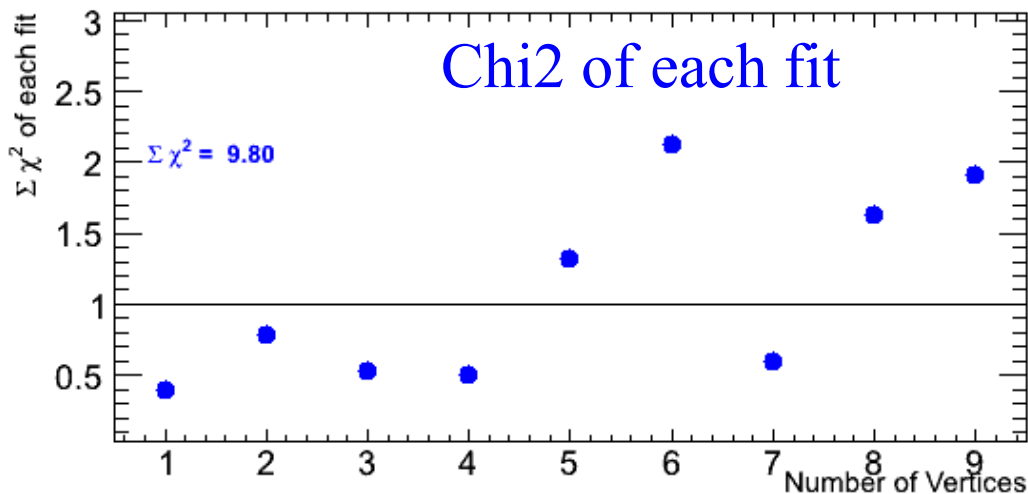


Each fit provides an estimate of the cross section.

The fit to these 9 values gives the final value:

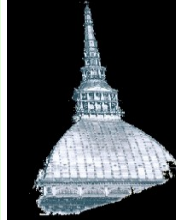
$\sigma(pp) = 58.7 \text{ mb}$
(2 charged particles with $p_t > 200 \text{ MeV}$ in $|\eta| < 2.4$)

ξ ($\xi = M_x^2/s$) interval: $> 6 * 10^{-5}$





Main Systematic Errors



Luminosity:

The CMS luminosity value is known with a precision of 4% : $\Delta\sigma = 2.4 \text{ mb}$

Analysis:

Use a different set of primary events (single mu or double electron): $\Delta\sigma = 0.9 \text{ mb}$

Change the fit limit by 0.05: $\Delta\sigma = 0.2 \text{ mb}$

Change the minimum distance between vertices (0.06 – 0.2 cm): $\Delta\sigma = 0.3 \text{ mb}$

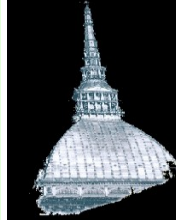
Change the vertex quality requirement (NDOF (0.5 – 2) & Trans. cut, & number of minimum tracks at reconstruction) : $\Delta\sigma = 1.0 \text{ mb}$

Use an analytic method instead of a MC: $\Delta\sigma = 1.4 \text{ mb}$

$$\sigma(\text{pp}) = 58.7 \pm 2.0 (\text{Syst}) \pm 2.4 (\text{Lum}) \text{ mb}$$

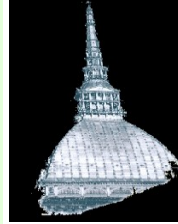
(2 charged particles with $p_t > 200 \text{ MeV}$ in $|\eta| < 2.4$)

Additional measurements

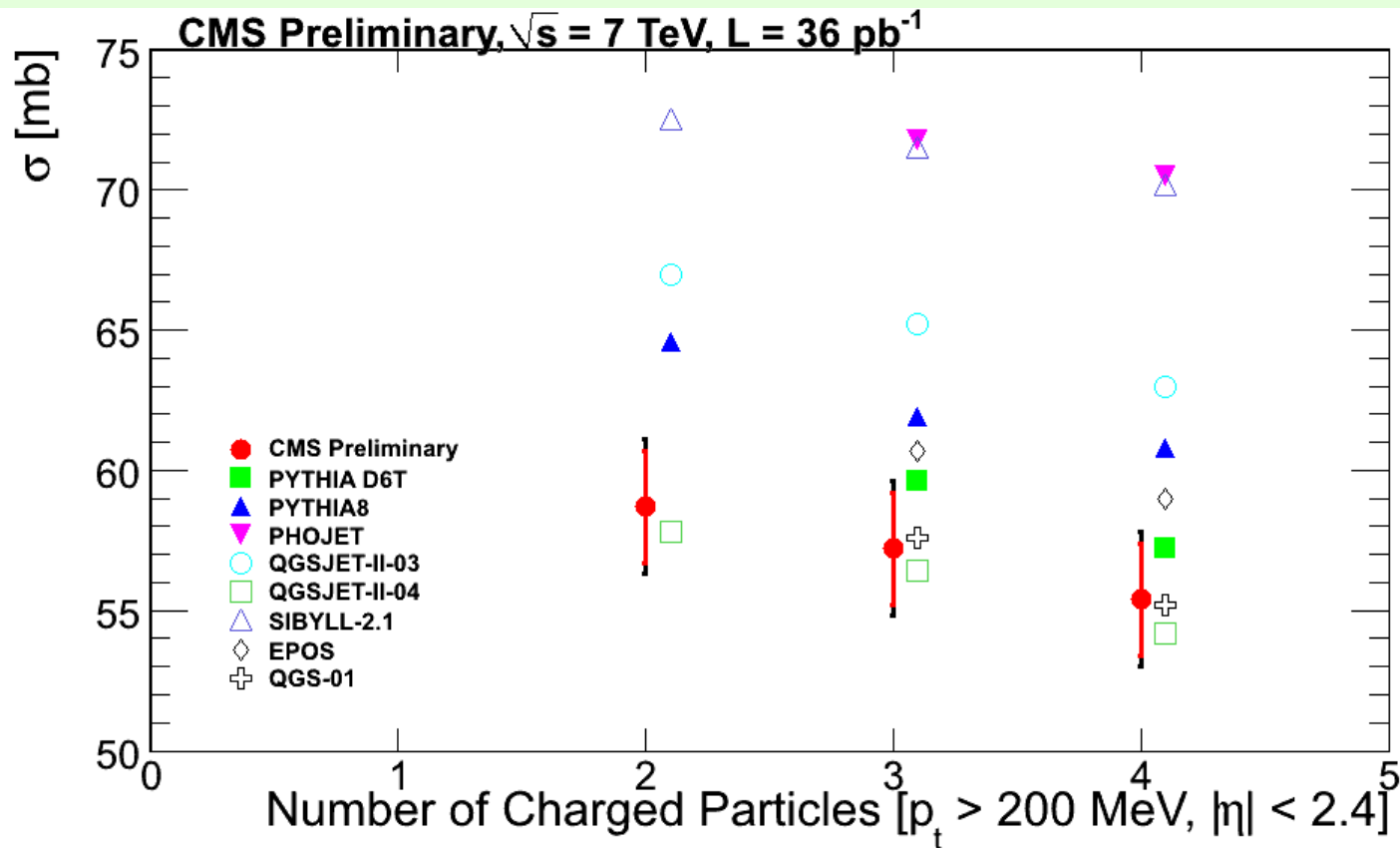


Using the same technique we measured 4 different cross sections:

- 2 charged particles with $p_t > 200$ MeV in $|\eta| < 2.4$
 $\sigma(pp) = 58.7 \pm 2.0$ (Syst) ± 2.4 (Lum) mb
- 3 charged particles with $p_t > 200$ MeV in $|\eta| < 2.4$
 $\sigma(pp) = 57.2 \pm 2.0$ (Syst) ± 2.4 (Lum) mb
- 4 charged particles with $p_t > 200$ MeV in $|\eta| < 2.4$
 $\sigma(pp) = 55.4 \pm 2.0$ (Syst) ± 2.4 (Lum) mb
- 3 particles with $p_t > 200$ MeV in $|\eta| < 2.4$
 $\sigma(pp) = 59.7 \pm 2.0$ (Syst) ± 2.4 (Lum) mb



Comparison with Models and Extrapolation to $\sigma_{\text{inel}}(\text{pp})$



We compared to several models and we defined a range of values for the extrapolation factor to go from the measured values to the total cross inelastic cross section:

$$\sigma_{\text{inel}}(\text{pp}) = 63 - 72 \text{ mb}$$

Comparison with Models - I

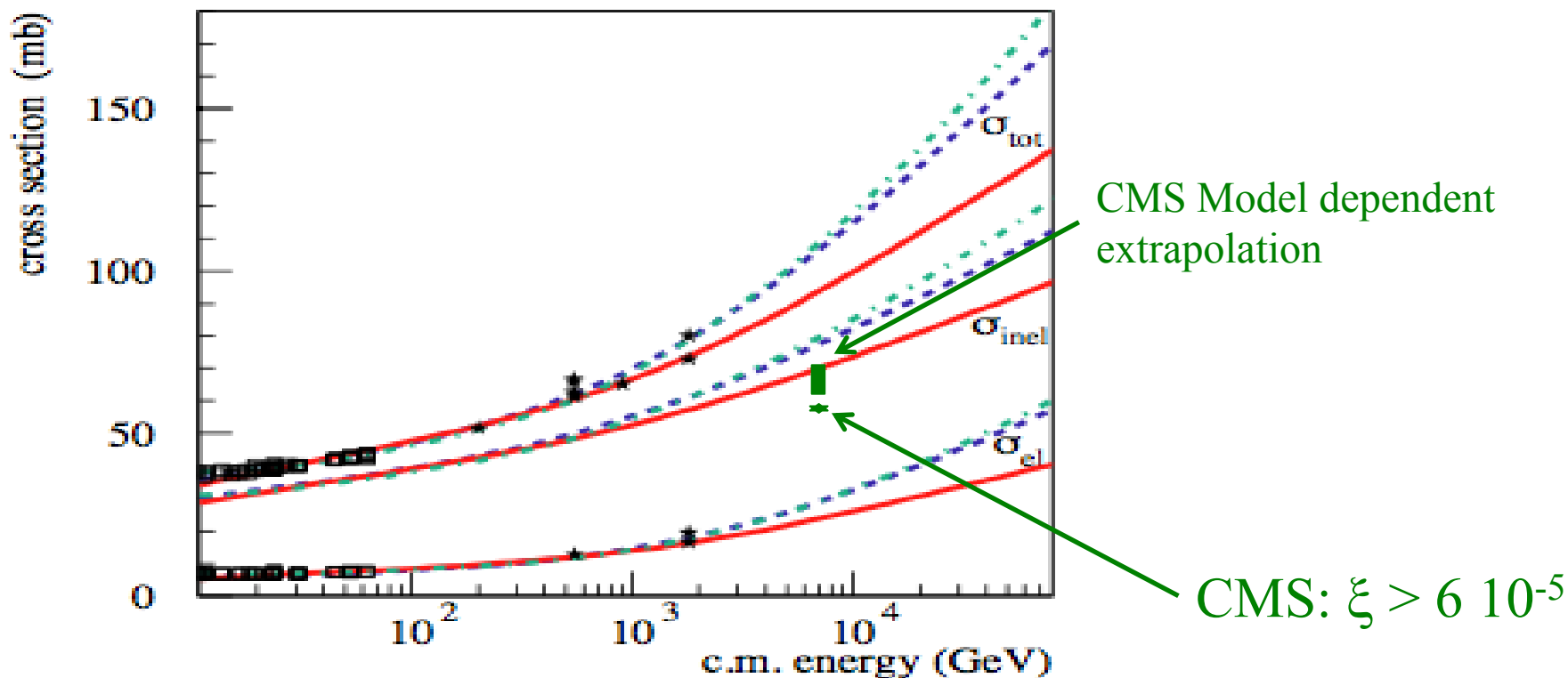
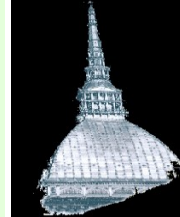
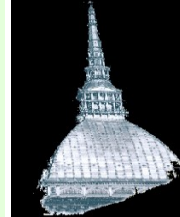
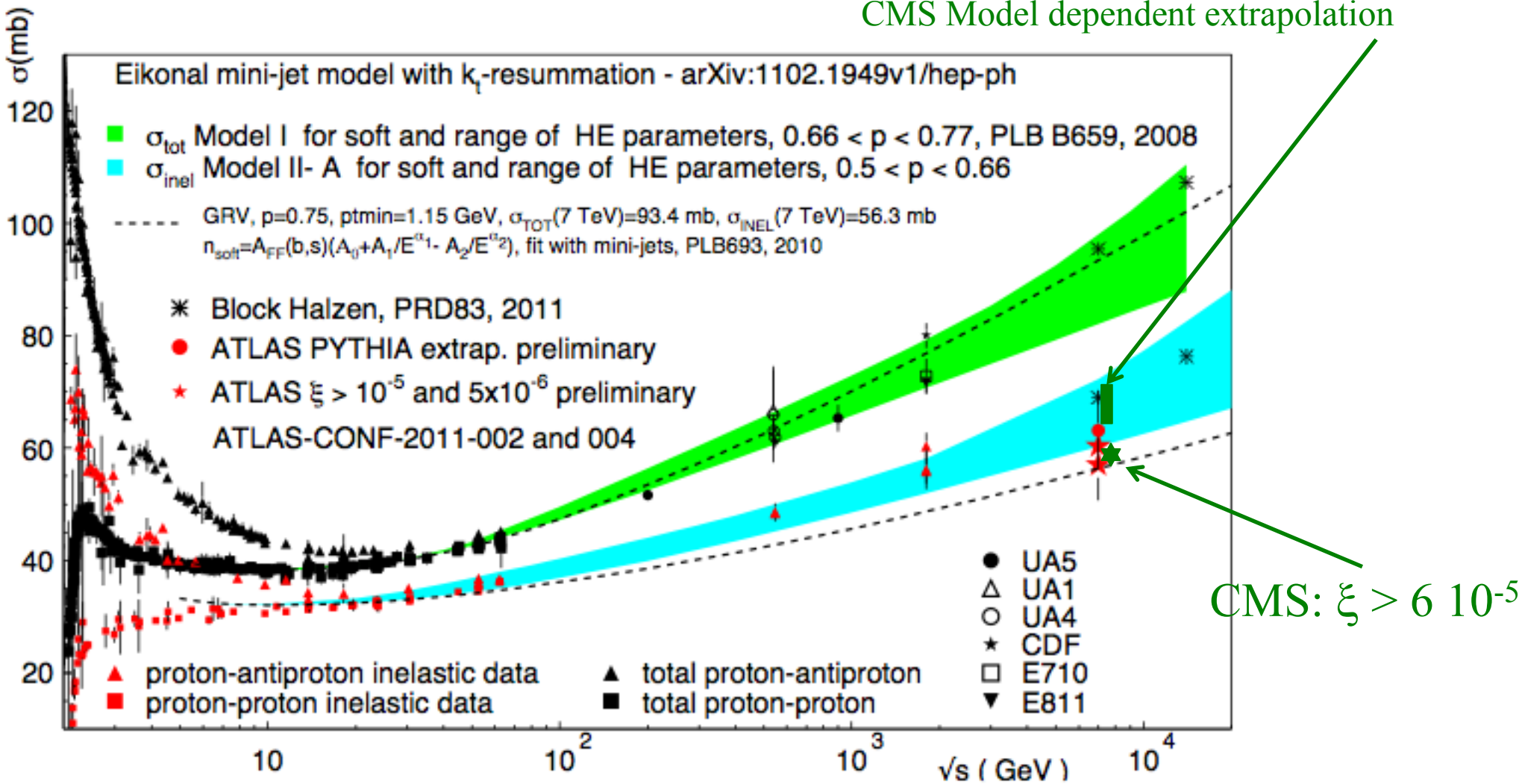


Figure 1: Model predictions for total, elastic, and inelastic proton-proton cross sections: QGSJET-II-4 - solid, QGSJET-II-3 - dashed, and SIBYLL - dot-dashed. The compilation of data is from Ref. [17].

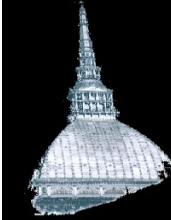
Comparison with Models, Results - II



CMS Model dependent extrapolation



Summary



We have developed a new method to measure the inelastic pp cross section

The value for 2 tracks, $|\eta| < 2.4$ and $p_t > 200$ MeV ($\xi > 6 \cdot 10^{-5}$) is:

$$\sigma = 58.7 \pm 2 \text{ (Sys)} \pm 2.4 \text{ (Lum)} \text{ mb}$$

Systematic checks show that the largest uncertainty derives from the luminosity measurement.

Using Monte Carlo - driven extrapolations we obtain a value for the total inelastic pp cross section in the range:

$$\sigma_{\text{inel}}(\text{pp}) = 68 \pm 2 \text{ (Sys)} \pm 2.4 \text{ (Lum)} \pm 4 \text{ (Extrap)} \text{ mb}$$